

Notice of References Cited	Application/Control No. 10/575,550		Applicant(s)/Patent Under Reexamination TAKEMASU ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0168559	09-2004	Ide et al.	083/684
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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